### STL40N75LF3



# N-channel 75 V, 16 mΩ typ., 10 A STripFET™ III Power MOSFET in a PowerFLAT™ 5x6 package

Datasheet - production data

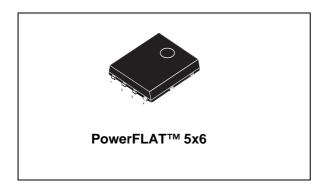
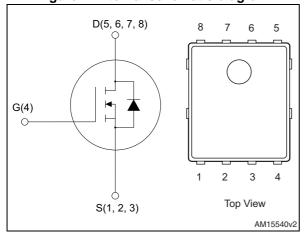


Figure 1. Internal schematic diagram



#### **Features**

Order code	V <sub>DSS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>
STL40N75LF3	75 V	19 m $\Omega$	10 A

- N-channel enhancement mode
- · Low gate charge
- Low threshold voltage device

### **Applications**

· Switching applications

#### **Description**

This device is an N-channel enhancement mode Power MOSFET produced using STMicroelectronics' STripFET™ III technology, which is specifically designed to minimize onresistance and gate charge to provide superior switching performance.

Table 1. Device summary

Order code	Marking	Package	Packaging
STL40N75LF3	40N75LF3	PowerFLAT™ 5x6	Tape and reel

Contents STL40N75LF3

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STL40N75LF3 Electrical ratings

### 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage	75	V
V <sub>GS</sub>	Gate-source voltage	+20\-16	V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 25 °C	40	Α
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 100 °C	26	Α
I <sub>DM</sub> <sup>(1)(2)</sup>	Drain current (pulsed)	160	Α
I <sub>D</sub> (3)	Drain current (continuous) at T <sub>pcb</sub> = 25 °C	10	Α
I <sub>D</sub> <sup>(3)</sup>	Drain current (continuous) at T <sub>pcb</sub> =100 °C	6	Α
P <sub>TOT</sub> <sup>(1)</sup>	Total dissipation at T <sub>C</sub> = 25 °C	75	W
P <sub>TOT</sub> (3)	Total dissipation at T <sub>pcb</sub> = 25 °C	4.8	W
T <sub>J</sub> T <sub>stg</sub>	Operating junction temperature Storage temperature	-55 to 175	°C

<sup>1.</sup> The value is rated according to  $R_{\mbox{\scriptsize thj-case}}$ 

Table 3. Thermal resistance

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case	2	°C/W
R <sub>thj-pcb</sub> (1)	Thermal resistance junction-ambient	31.3	°C/W

<sup>1.</sup> When mounted on FR-4 board of 1 inch $^2$ , 2oz Cu., t < 10 sec.

<sup>2.</sup> Pulse width limited by safe operating area

<sup>3.</sup> The value is rated according to  $R_{thj\text{-pcb}}$ 

Electrical characteristics STL40N75LF3

### 2 Electrical characteristics

(T<sub>CASE</sub> = 25 °C unless otherwise specified).

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage (V <sub>GS</sub> = 0)	I <sub>D</sub> = 250 μA	75			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 75 V, V <sub>DS</sub> = 75 V, T <sub>C</sub> = 125 °C			1 10	μA μA
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = +20 / -16 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1			V
R <sub>DS(on)</sub>	Static drain-source on resistance	$V_{GS}$ = 10 V, $I_{D}$ = 20 A $V_{GS}$ = 5 V, $I_{D}$ = 20 A		16 18.7	19 22	mΩ

#### Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz,}$ $V_{GS} = 0$	-	1300 228 15	-	pF pF pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD}$ = 37.5 V, $I_{D}$ = 40 A $V_{GS}$ = 5 V (see Figure 14)	-	12 5 5.3	-	nC nC nC
R <sub>G</sub>	Gate input resistance	f=1 MHz gate DC bias=0 Test signal level = 20 mV open drain	1	3.5	-	Ω

#### Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 37.5 \text{ V}, I_{D} = 20 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 13)	-	12 25 25 3	-	ns ns ns ns

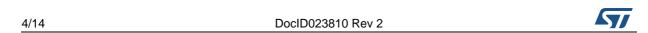


Table 7. Source-drain diode

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I <sub>SD</sub>	Source-drain current				40	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		160	Α
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> = 40 A, V <sub>GS</sub> =0	1		1.1	V
t <sub>rr</sub>	Reverse recovery time	$I_{SD} = 40 \text{ A},$		35		ns
$Q_{rr}$	Reverse recovery charge	di/dt = 100 A/μs,	-	44		nC
I <sub>RRM</sub>	Reverse recovery current	V <sub>DD</sub> =60 V		27		Α

<sup>1.</sup> Pulse width limited by safe operating area

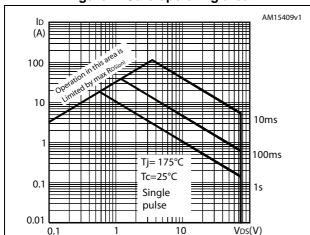
<sup>2.</sup> Pulsed: pulse duration=300µs, duty cycle 1.5%

**Electrical characteristics** STL40N75LF3

#### **Electrical characteristics (curves)** 2.1

Figure 2. Safe operating area

Figure 3. Thermal impedance



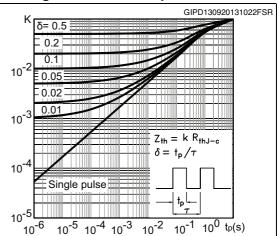
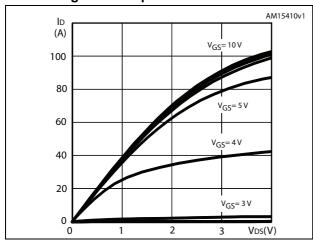


Figure 4. Output characteristics

Figure 5. Transfer characteristics



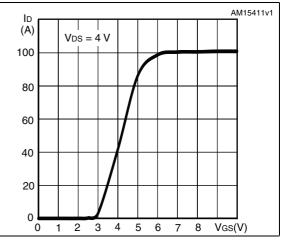
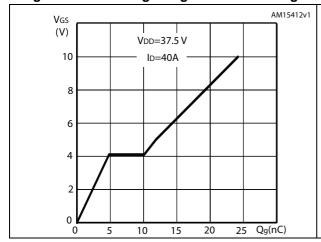


Figure 6. Gate charge vs gate-source voltage

Figure 7. Static drain-source on-resistance



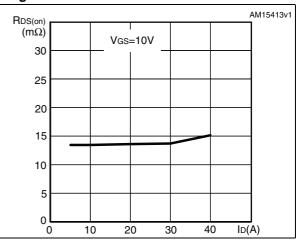
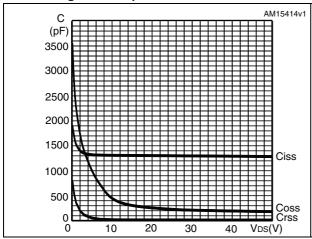


Figure 8. Capacitance variations

Figure 9. Normalized V(BR)<sub>DSS</sub> vs temperature



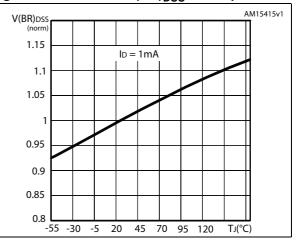
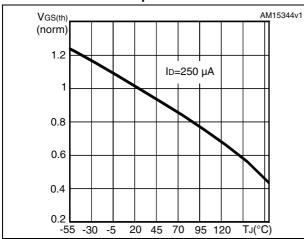


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on-resistance vs temperature



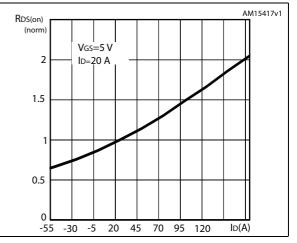
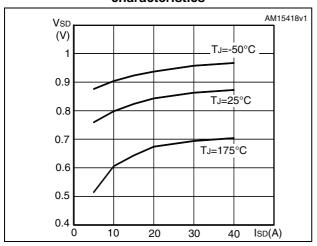


Figure 12. Source-drain diode forward characteristics



Test circuits STL40N75LF3

### 3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

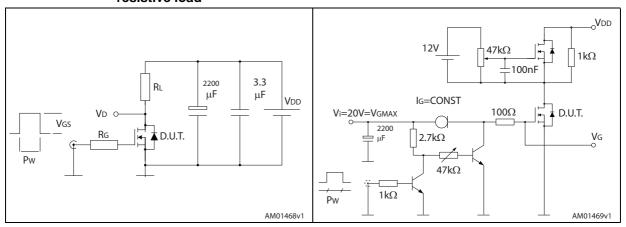


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped inductive load test circuit

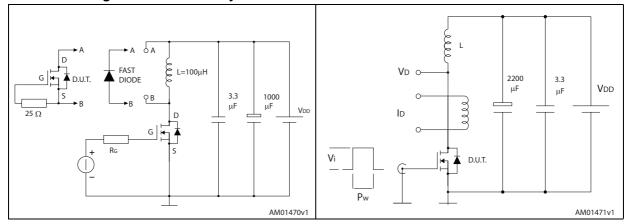
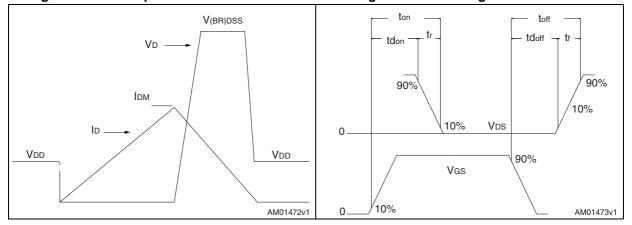


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



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### 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: <a href="https://www.st.com">www.st.com</a>. ECOPACK<sup>®</sup> is an ST trademark.

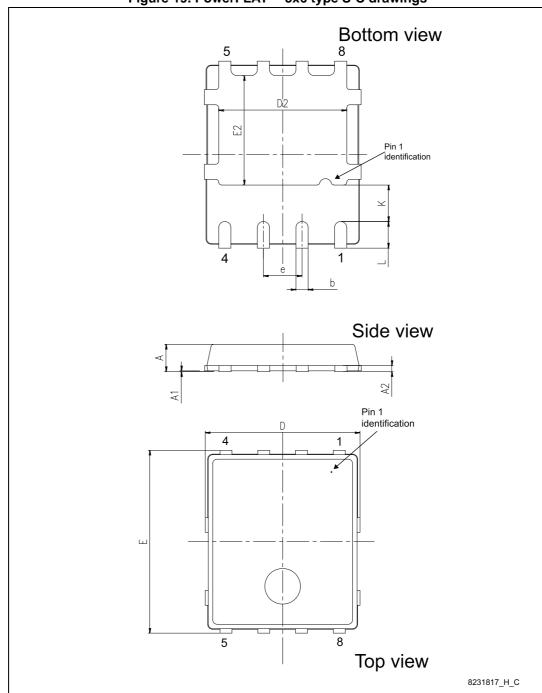
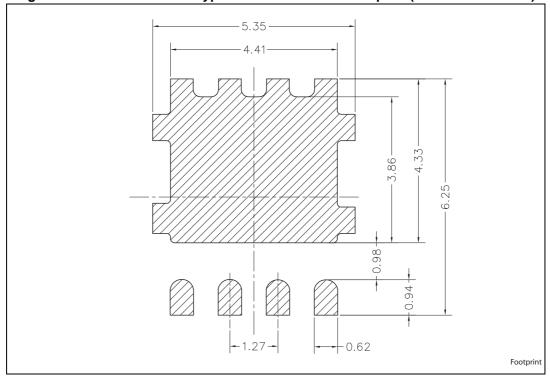


Figure 19. PowerFLAT™ 5x6 type S-C drawings

Table 8. PowerFLAT™ 5x6 type S-C mechanical data

	144010 011 011011 =211	exe type e e meeman	
Dim.		mm	
Dilli.	Min.	Тур.	Max.
А	0.80		1.00
A1	0.02		0.05
A2		0.25	
b	0.30		0.50
D		5.20	
E		6.15	
D2	4.11		4.31
E2	3.50		3.70
е		1.27	
e1		0.65	
L	0.715		1.015
K	1.05		1.35

Figure 20. PowerFLAT™ 5x6 type S-C recommended footprint (dimensions in mm)

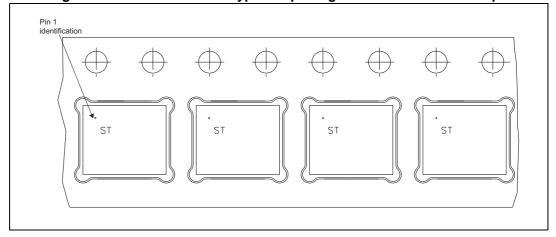


# 5 Packaging information

P<sub>0</sub> 4.0±0.1 (II) P<sub>2</sub> 2.0±0.1 (I) T (0.30±0.05) E<sub>1</sub> - 1.75±0.1 Do Ø1.55±0.05 D1 Ø1.5 MI<u>N.</u> F(5.50±0.1)(III) P1(8.00±0.1) Ao(6.30±0.1) Ko (1.20±0.1) SECTION Y-Y (I) Measured from centerline of sprocket hole to centerline of pocket. Base and bulk quantity 3000 pcs (II) Cumulative tolerance of 10 sprocket holes is  $\pm$  0.20 . (III) Measured from centerline of sprocket hole to centerline of pocket. 8234350\_Tape\_rev\_C

Figure 21. PowerFLAT™ 5x6 type S-C tape

Figure 22. PowerFLAT™ 5x6 type S-C package orientation in carrier tape



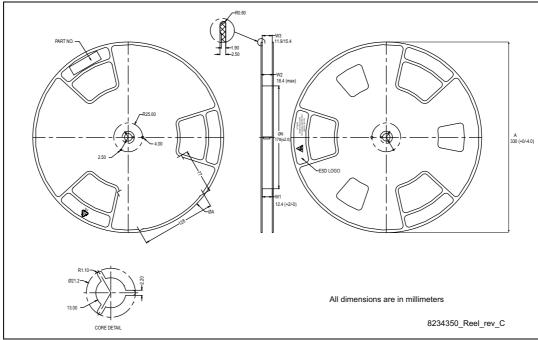


Figure 23. PowerFLAT™ 5x6 type S-C reel



STL40N75LF3 Revision history

# 6 Revision history

**Table 9. Document revision history** 

Date	Revision	Changes
19-Oct-2012	1	First release.
24-Feb-2014	2	Deleted note in the table of <i>Features</i> .  Updated <i>Figure 1</i> .  Updated values of P <sub>TOT</sub> , T <sub>J</sub> and T <sub>stg</sub> in <i>Table 2</i> .  Updated notes in <i>Table 2</i> .  Updated V <sub>GS</sub> test condition in <i>Table 5</i> .  Updated V <sub>DD</sub> test condition in <i>Table 6</i> .  Removed T <sub>j</sub> test condition from <i>Table 7</i> .  Updated <i>Figure 2</i> , <i>Figure 4</i> , <i>Figure 6</i> , <i>Figure 9</i> and <i>Figure 11</i> .  Updated mechanical data.

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